

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10574482	YAHIRO ET AL.
	Examiner Chen, Catheryne	Art Unit 1655

SEARCHED

Class	Subclass	Date	Examiner
none	none	6/20/07	CC

SEARCH NOTES

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INTERFERENCE SEARCH

Class	Subclass	Date	Examiner